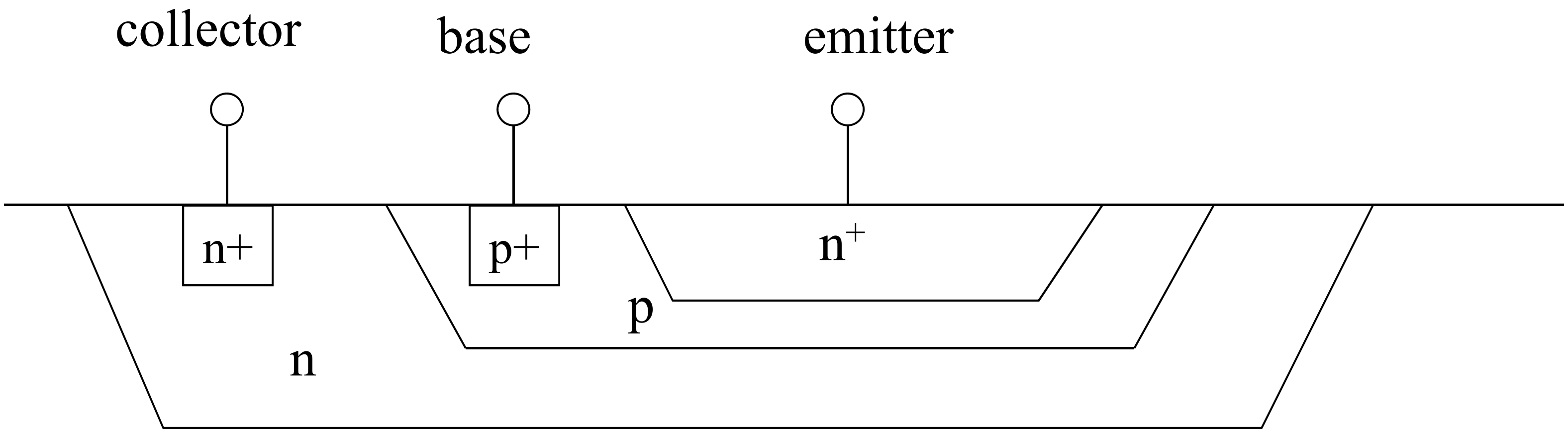
Bipolar transistors

bipolar transistors

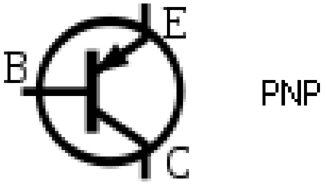
npn transistor

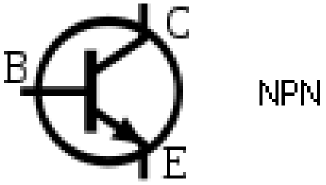


lightly doped p substrate

Used in front-end high-frequency receivers (mobile telephones).

bipolar transistors





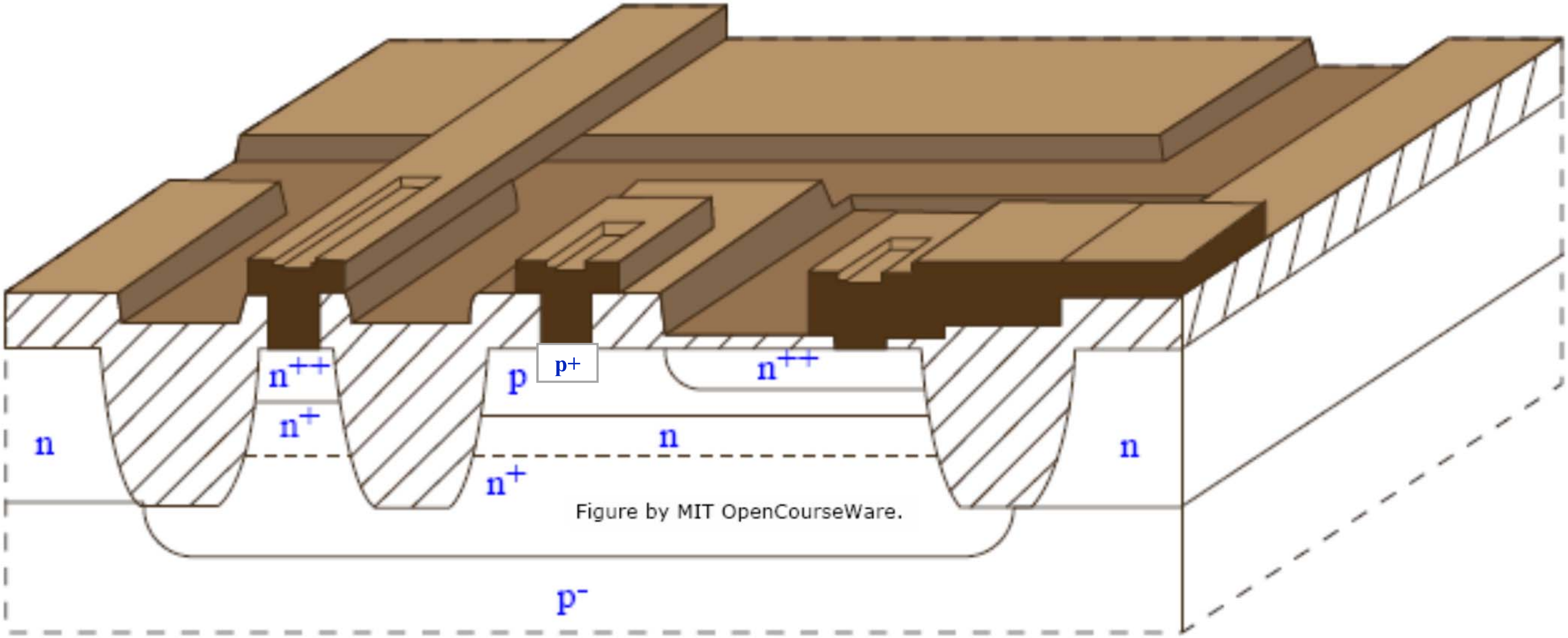
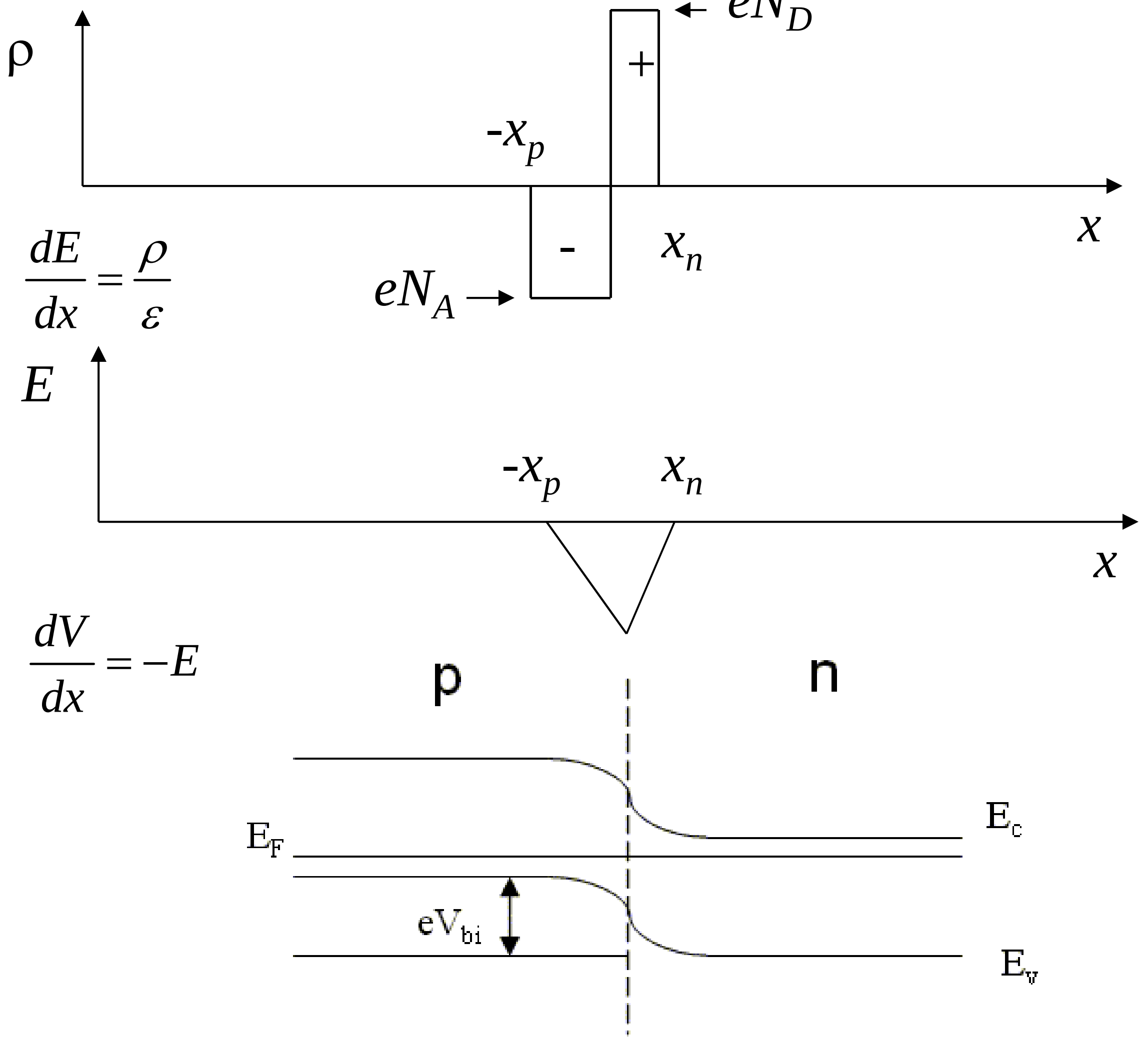


Figure by MIT OpenCourseWare.

Oxide isolated integrated BJT - a modern process

abrupt junction

$$eV_{bi} = k_B T \ln\left(\frac{N_D N_A}{n_i^2}\right)$$



$$\frac{dE}{dx} = \frac{\rho}{\varepsilon}$$

$$\frac{dV}{dx} = -E$$

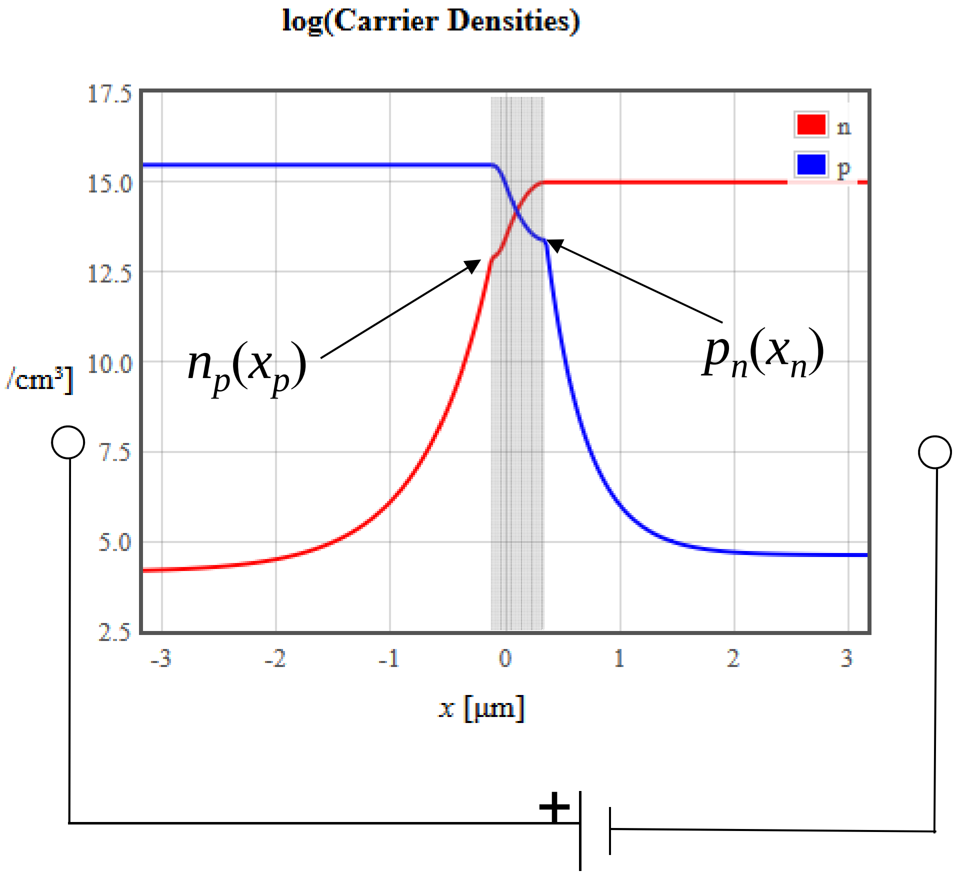
$$E = -\frac{eN_A}{\varepsilon}\left(x + x_p\right) \qquad -x_p > x > 0$$

$$E = \frac{eN_D}{\varepsilon}\left(x - x_n\right) \qquad 0 > x > x_n$$

$$V = \frac{eN_A}{\varepsilon}\left(\frac{x^2}{2} + xx_p\right) \qquad -x_p > x > 0$$

$$V = \frac{-eN_D}{\varepsilon}\left(\frac{x^2}{2} - xx_n\right) \qquad 0 > x > x_n$$

Forward bias, V > 0



Electrons and holes are driven towards the junction.
The depletion region becomes narrower

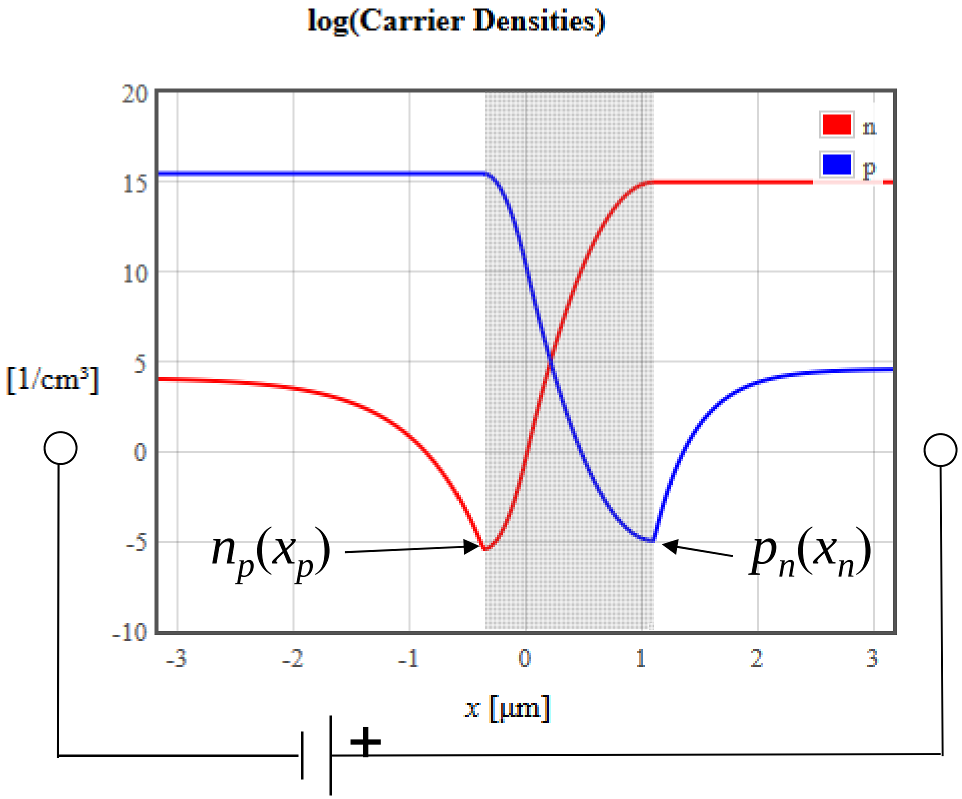
$$n_p(x_p) = n_{p0}\exp\left(\frac{eV}{k_BT}\right)$$

$$p_n(x_n) = p_{n0}\exp\left(\frac{eV}{k_BT}\right)$$

$$p_{e0}\exp\left(\frac{eV_{be}}{k_BT}\right)$$

Minority electrons are injected into the p-region
Minority holes are injected into the n-region

Reverse bias, V < 0



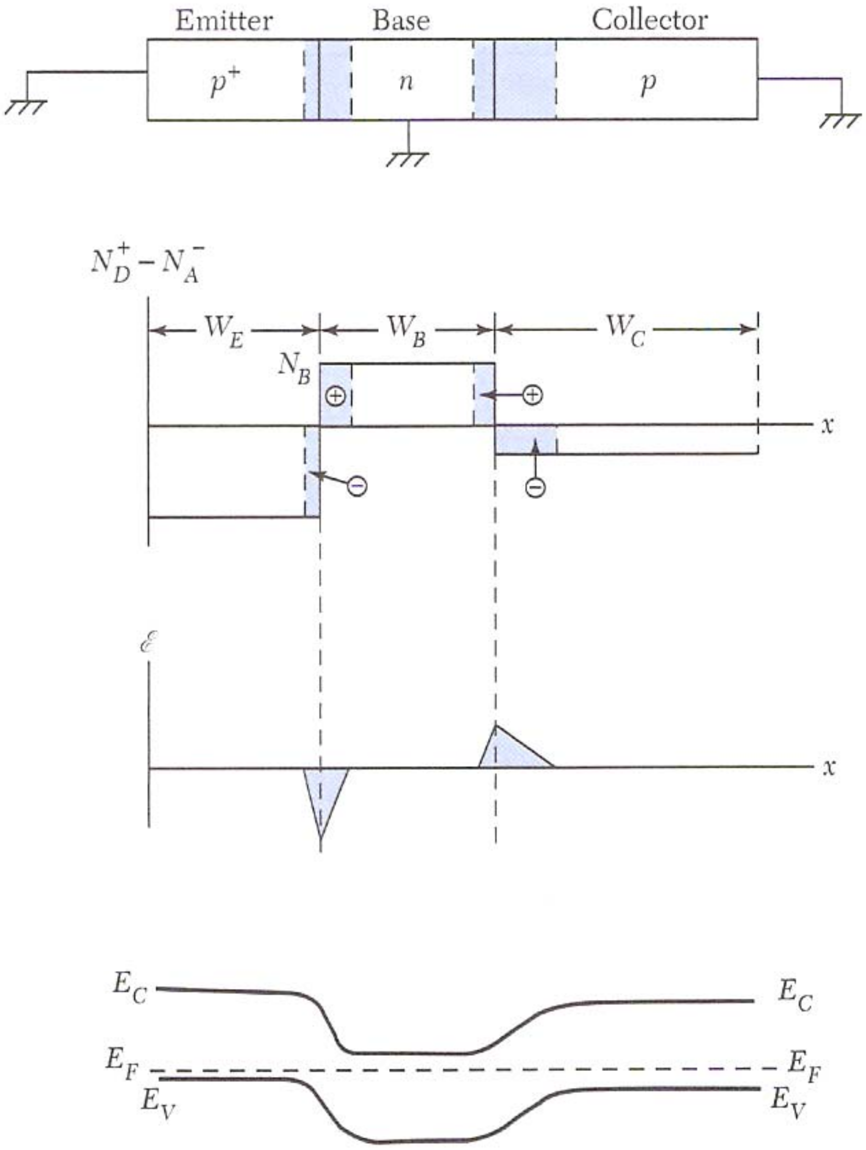
Electrons and holes are driven away from the junction.
The depletion region becomes wider

$$n_p(x_p) = n_{p0} \exp\left(\frac{eV}{k_B T}\right)$$

$$p_n(x_n) = p_{n0} \exp\left(\frac{eV}{k_B T}\right)$$

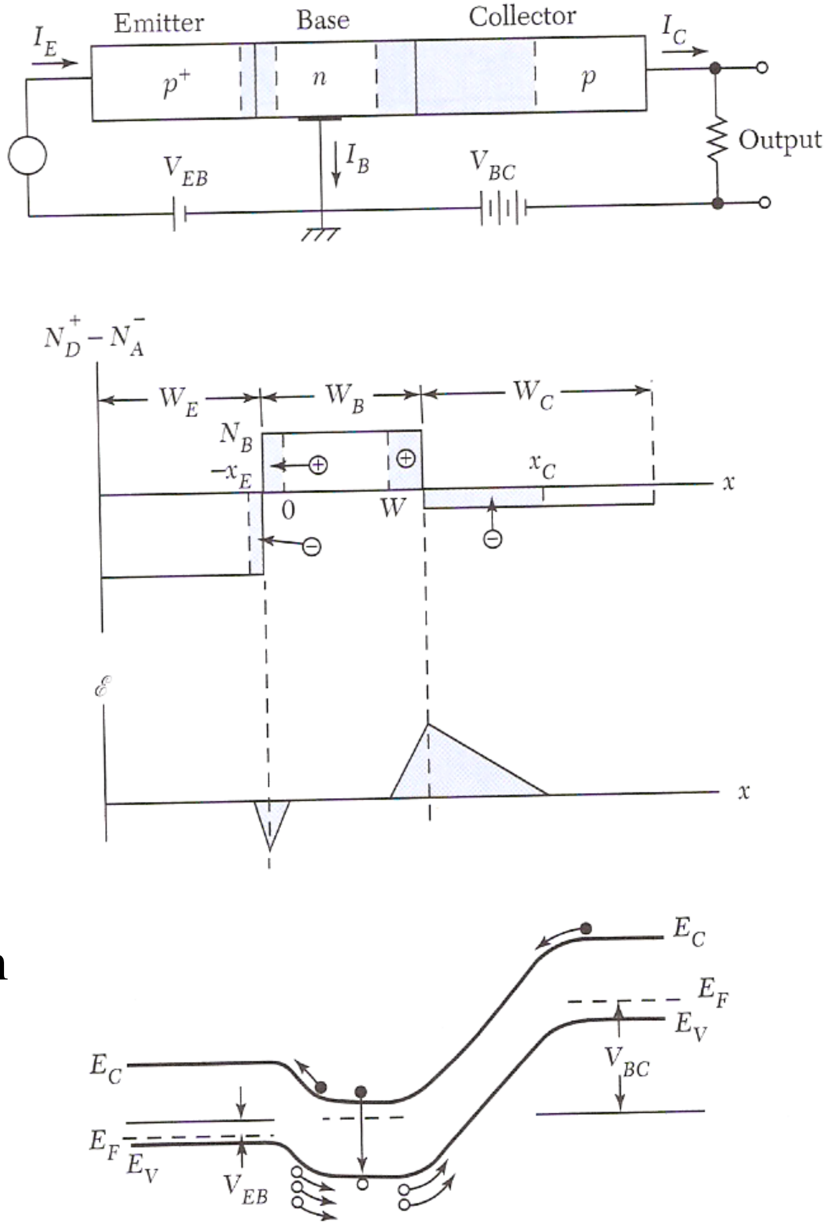
Minority electrons are extracted from the p-region by the electric field
Minority holes are extracted from the n-region by the electric field

pnp transistor, no bias



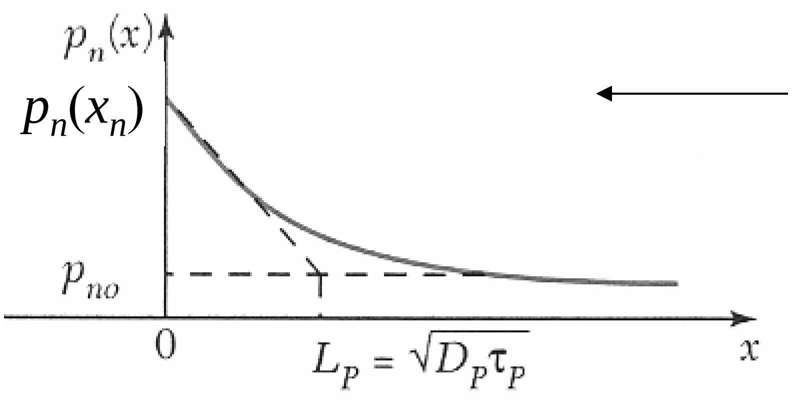
pnp transistor, forward active bias

The base-emitter voltage controls the minority carriers injected from the emitter to the base. These diffuse to the base-collector junction and are swept into the collector.

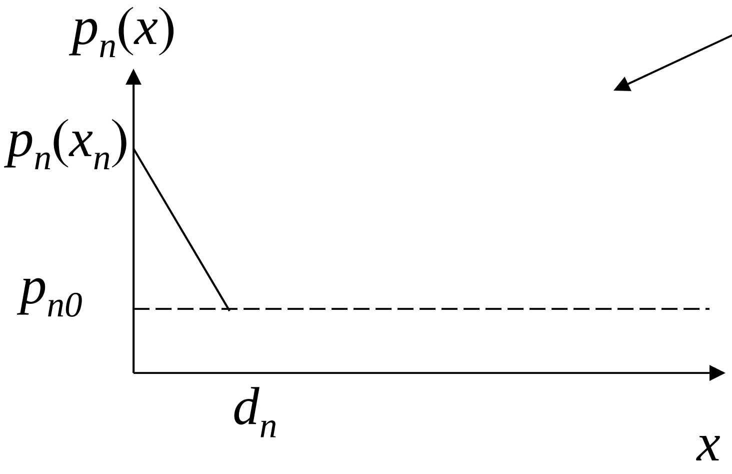


Always dissipate power due to the forward bias

Long/Short diode



Long diode $d_n >> L_p$



Short diode

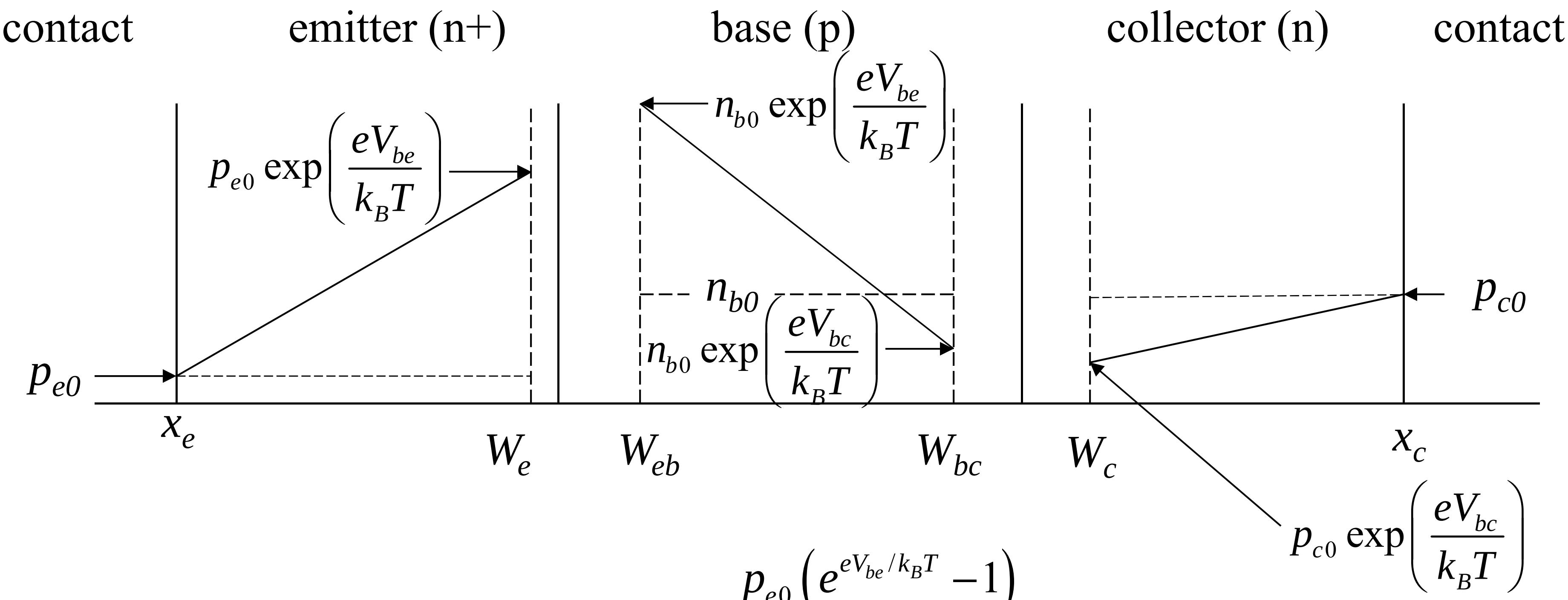
$d_n << L_p$

Metal contact is much closer to the depletion region than the diffusion length

$$J_{diff,p} = eD_p \frac{dp}{dx}$$

$$J_{diff,p} = eD_p \frac{dp}{dx} = eD_p \frac{\left(p_n(x_n) - p_{n0}\right)}{d_n}$$

Minority carrier concentration



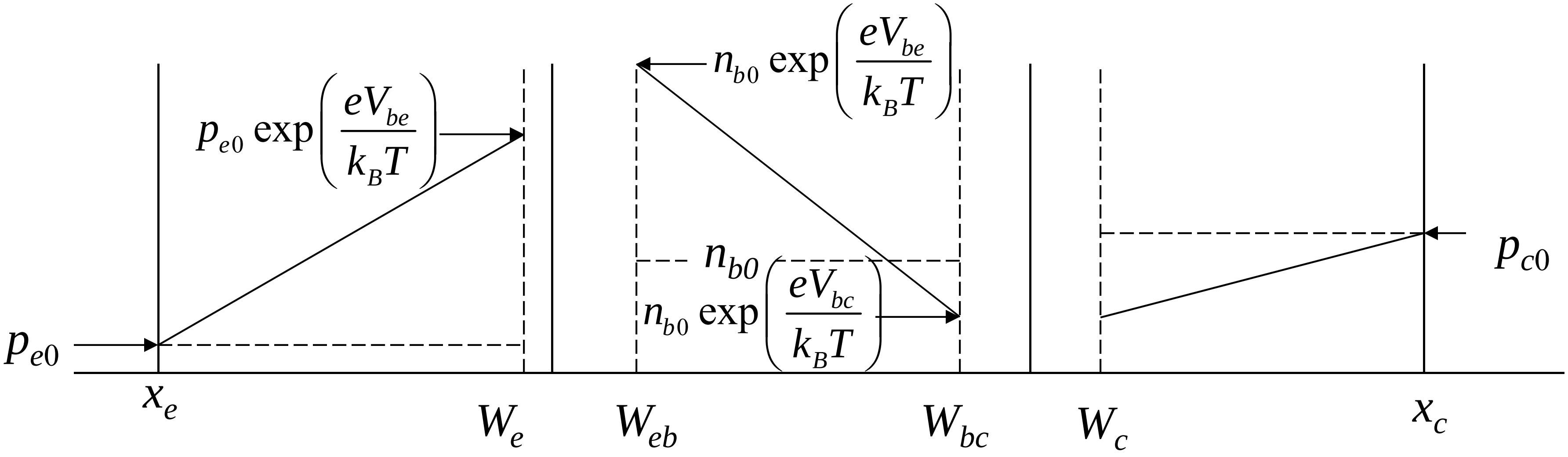
$$I_{Ep} = eA_{be}D_p \frac{p_{e0}\left(e^{eV_{be}/k_BT} - 1\right)}{W_e - x_e}$$

$$I_{En} = -eA_{be}D_n \frac{n_{b0}\left(e^{eV_{be}/k_BT} - e^{eV_{bc}/k_BT}\right)}{W_{bc} - W_{be}}$$

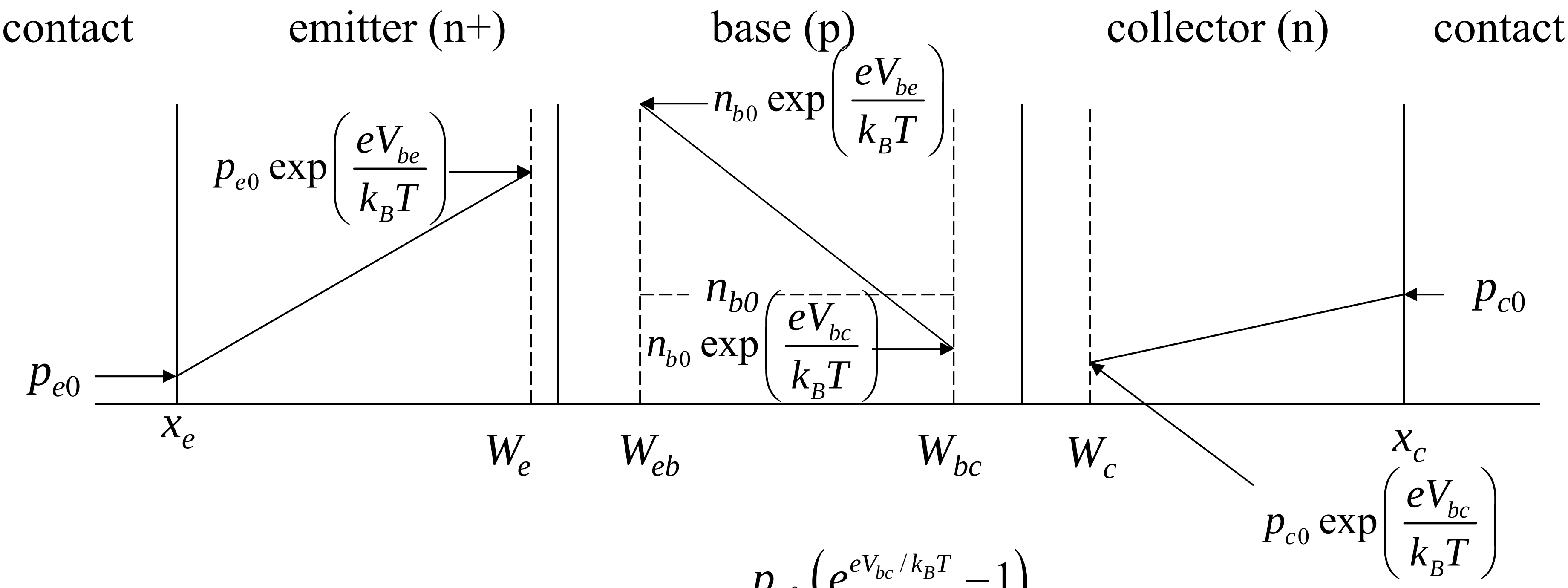
Emitter current

$$I_E = I_{En} + I_{Ep} = \left[\frac{eA_{be}D_p p_{e0}}{W_{eb} - x_e} + \frac{eA_{be}D_n n_{b0}}{W_{bc} - W_{be}}\right]\left(e^{eV_{be}/k_BT} - 1\right) - \frac{eA_{be}D_n n_{b0}}{W_{bc} - W_{be}}\left(e^{eV_{bc}/k_BT} - 1\right)$$

$$I_E = I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) - \alpha_R I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$



Collector current



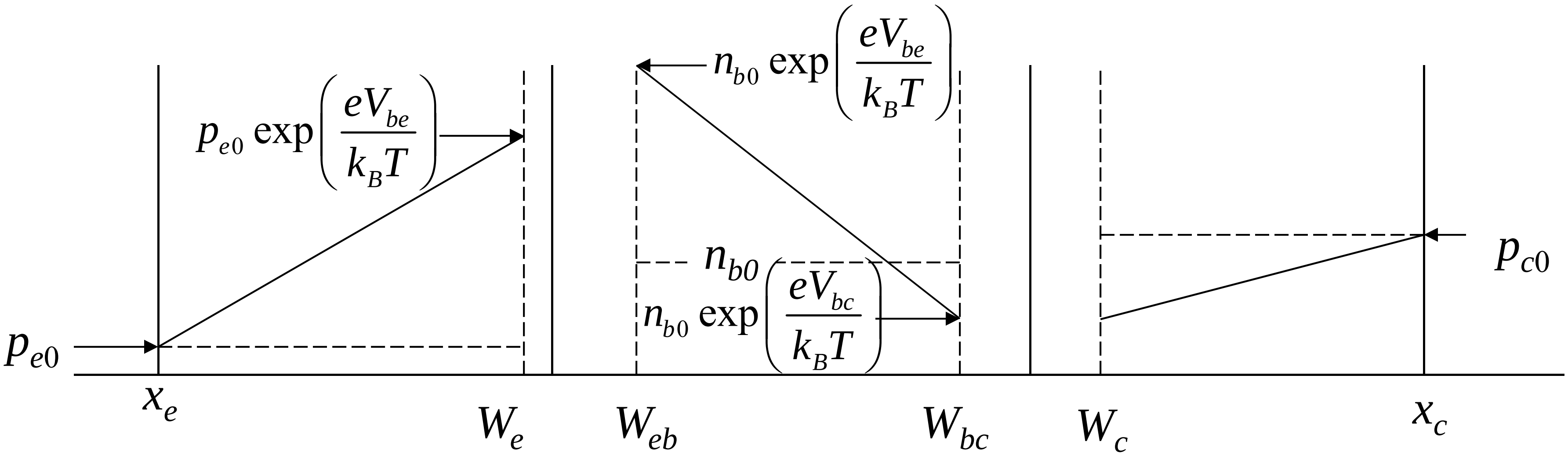
$$I_{cp} = -eA_{bc}D_p \frac{p_{c0}\left(e^{eV_{bc}/k_BT}-1\right)}{x_c - W_c}$$

$$I_{cn} = -eA_{bc}D_n \frac{n_{b0}\left(e^{eV_{be}/k_BT}-e^{eV_{bc}/k_BT}\right)}{W_{bc} - W_{eb}}$$

Collector current

$$I_c = I_{cp} + I_{cn} = \frac{eA_{bc}D_n n_{b0}}{W_{bc} - W_{be}}\left(e^{eV_{be}/k_BT} - 1\right) - \left[\frac{eA_{bc}D_p p_{c0}}{x_c - W_c} + \frac{eA_{bc}D_n n_{b0}}{W_{bc} - W_{be}}\right]\left(e^{eV_{bc}/k_BT} - 1\right)$$

$$I_c = I_{cp} + I_{cn} = \alpha_F I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) - I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$

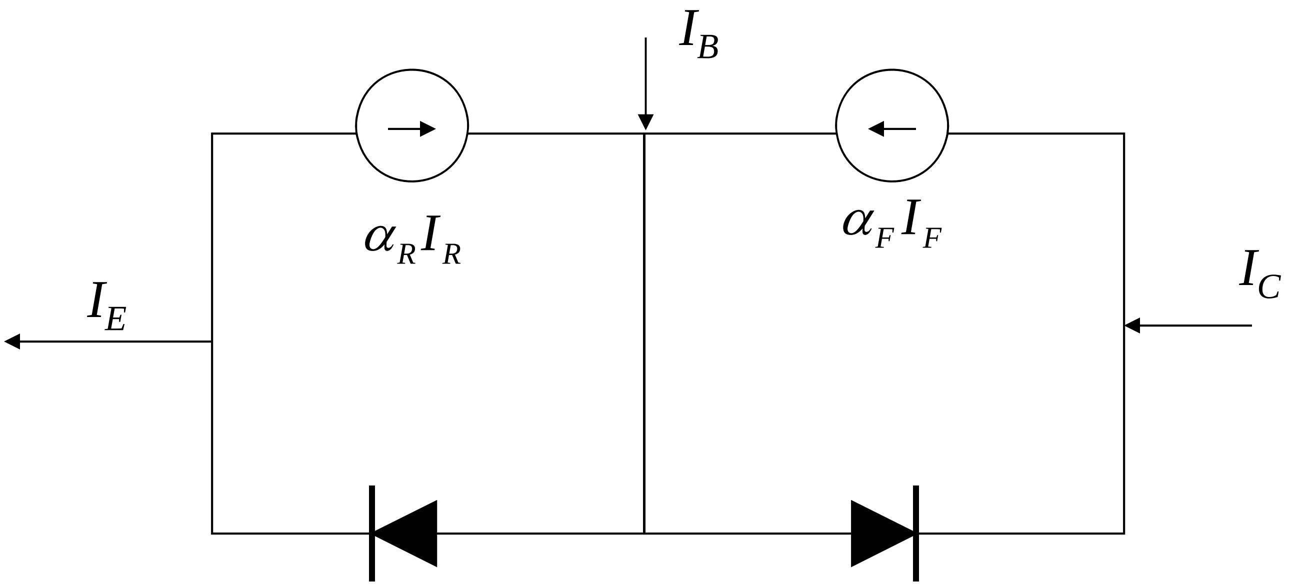


Ebers-Moll model

$$I_E = I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) - \alpha_R I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$

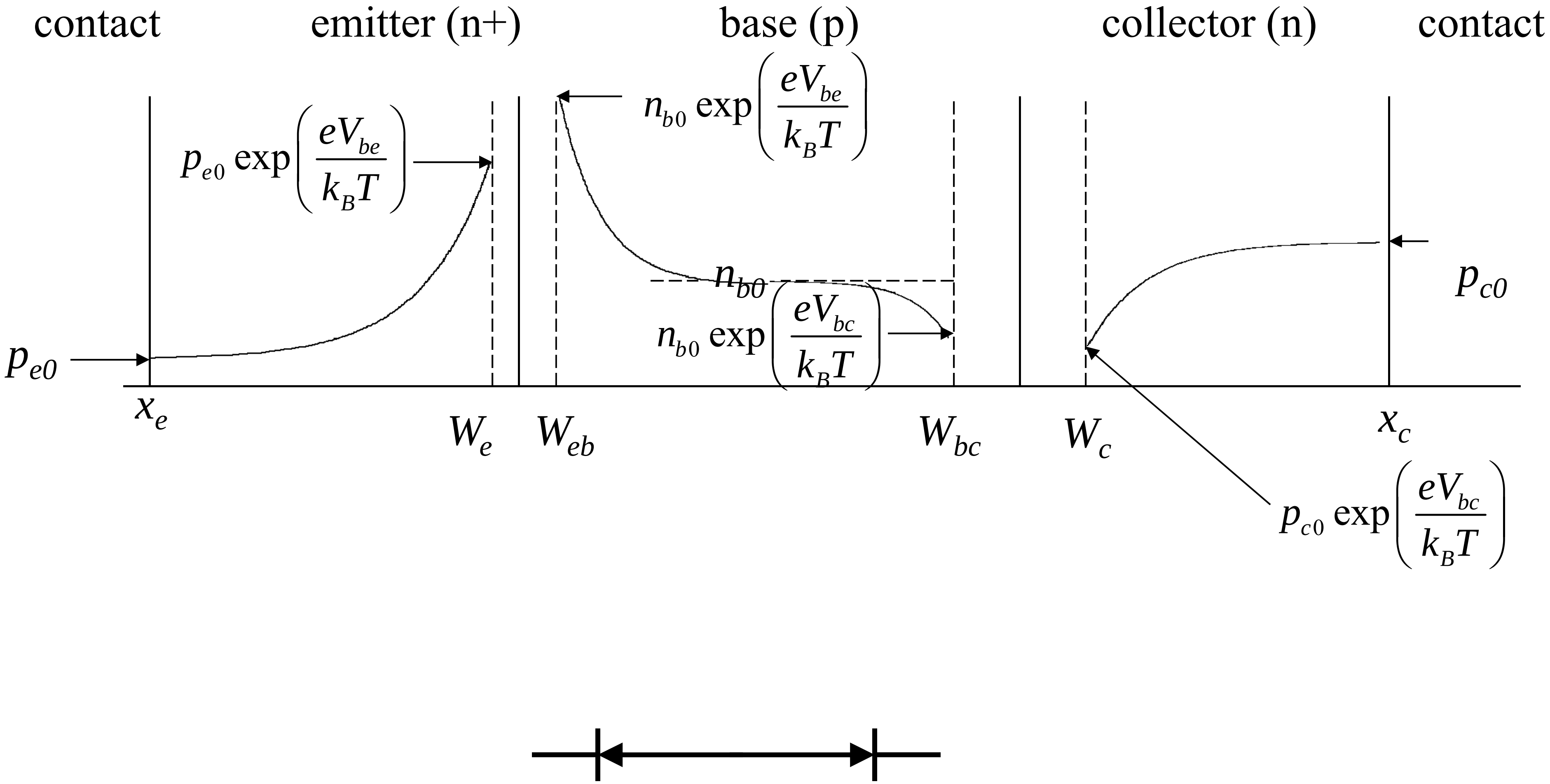
$$I_C = \alpha_F I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) - I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$

$$I_B = I_E - I_C$$



$$I_F = I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) \qquad I_R = I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$

Not an npn transistor



Emitter efficiency

$$\gamma_e = \frac{I_{En}}{I_{En}+I_{Ep}} = \frac{1}{1+I_{Ep}/I_{En}}$$

for npn

$$I_{Ep} = eA_{be}D_p \frac{p_{e0}\left(e^{eV_{be}/k_BT}-1\right)}{W_{eb}-x_e}$$

$$I_{En} = -eA_{be}D_n \frac{n_{b0}\left(e^{eV_{be}/k_BT}-e^{eV_{bc}/k_BT}\right)}{W_{bc}-W_{be}}$$

For $\gamma_e \sim 1$, $W_{bc} - W_{be} << L_b$, $W_{eb} - x_e$ and $n_{b0} >> p_{e0}$

neutral base width

$$\frac{n_i^2}{N_{Ab}}$$

$$\frac{n_i^2}{N_{De}}$$

Small base width and heavy emitter doping

Base transport factor

$$B = \frac{I_c}{I_{En}}$$

ratio of the injected current to the collected current

recombination in the base would reduce the base transport factor

A thin base with low doping results in a base transport factor ~ 1

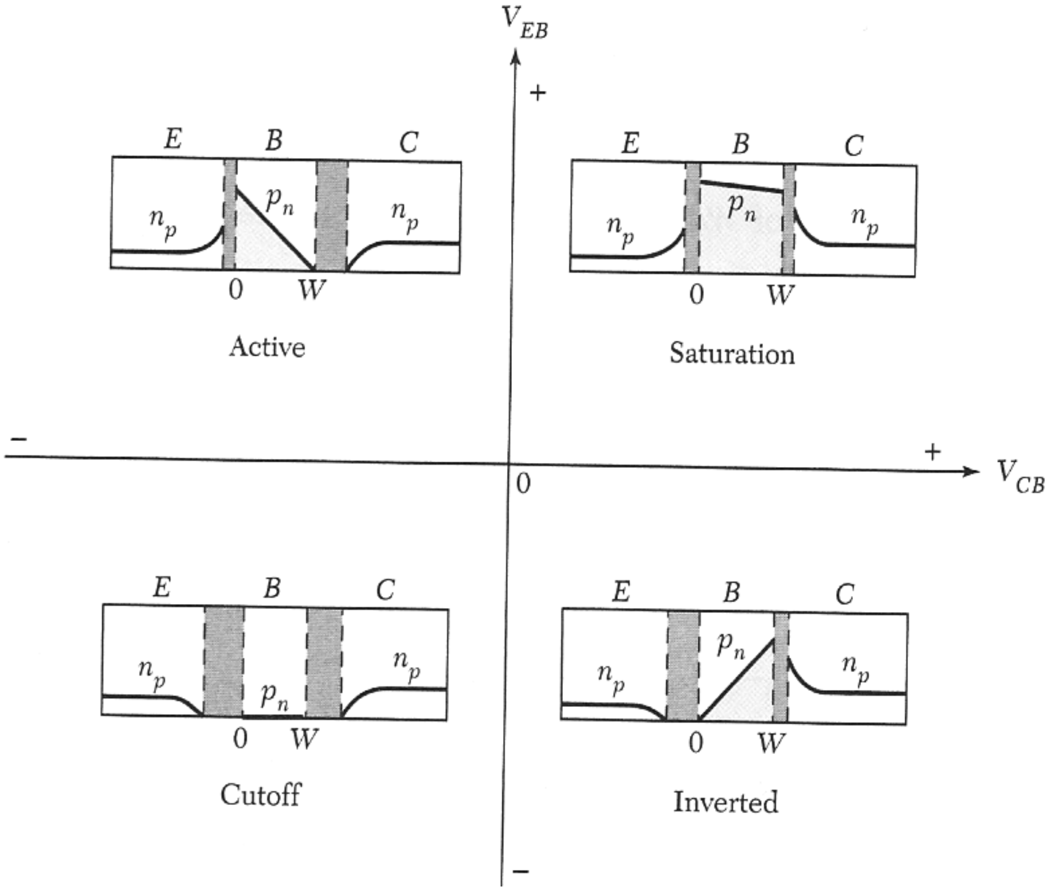
Current transfer ratio

$$\alpha = \frac{I_C}{I_E} = B\gamma_e$$

α ~ 1 for a good BJT

Transistor modes

1. Forward active: emitter-base **forward**, base-collector **reverse**
2. Saturation: emitter-base **forward**, base-collector **forward**
3. Reverse active: emitter-base **reverse**, base-collector **forward**
4. Cut-off: emitter-base **reverse**, base-collector **reverse**

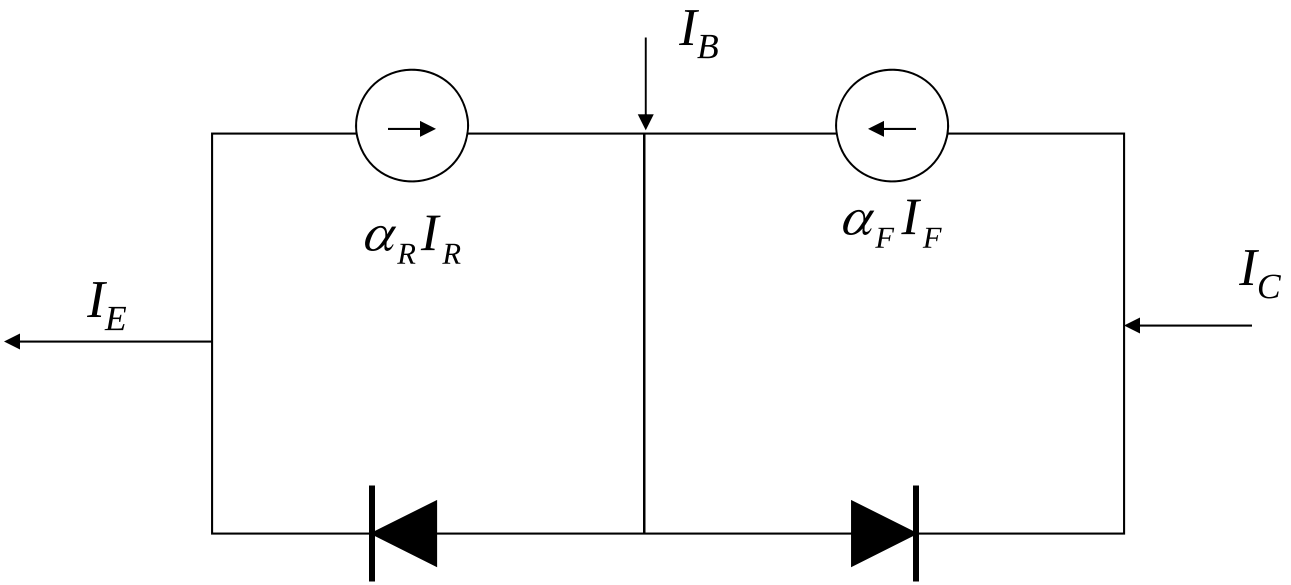


Ebers-Moll model

$$I_E = I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) - \alpha_R I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$

$$I_C = \alpha_F I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) - I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$

$$I_B = I_E - I_C$$



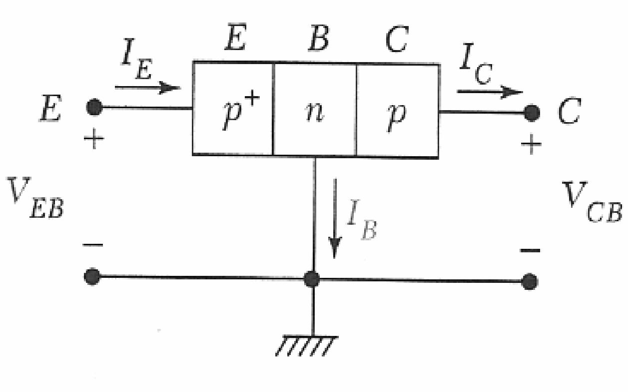
$$I_F = I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) \qquad I_R = I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$

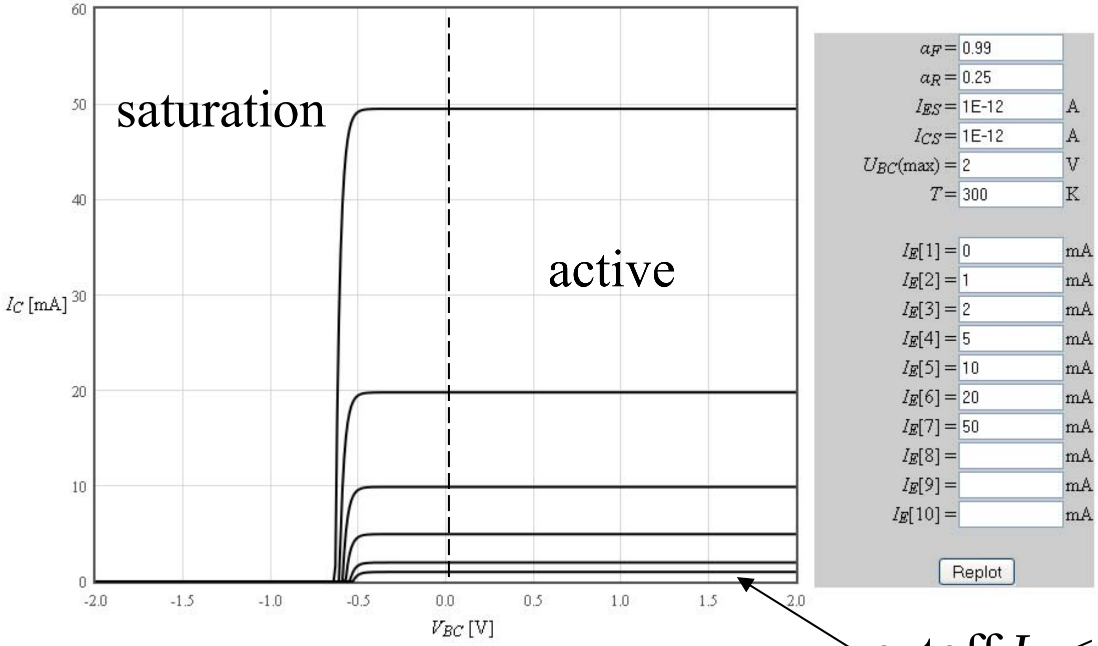
Common base configuration

$$I_E = I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) - \alpha_R I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$

solve for V_{be}

$$I_c = \alpha_F I_{ES}\left(e^{eV_{be}/k_BT} - 1\right) - I_{CS}\left(e^{eV_{bc}/k_BT} - 1\right)$$





saturation

active

$\alpha_F =$ 0.99

$\alpha_R =$ 0.25

$I_{ES} =$ 1E-12 A

$I_{CS} =$ 1E-12 A

U_{BC}(max) = 2 V

$T =$ 300 K

$I_E[1] =$ 0 mA

$I_E[2] =$ 1 mA

$I_E[3] =$ 2 mA

$I_E[4] =$ 5 mA

$I_E[5] =$ 10 mA

$I_E[6] =$ 20 mA

$I_E[7] =$ 50 mA

$I_E[8] =$ mA

$I_E[9] =$ mA

$I_E[10] =$ mA

cutoff $I_E < 0$

http://lamp.tu-graz.ac.at/~hadley/psd/L13/commonbase/pnp_current.html

Ebers - Moll Model

$$I_{ES} = \left[\frac{eA_{be} D_p p_{e0}}{W_{eb} - x_e} + \frac{eA_{be} D_n n_{b0}}{W_{bc} - W_{be}} \right]$$

$$\alpha_R I_{CS} = \frac{eA_{be} D_n n_{b0}}{W_{bc} - W_{be}}$$

$$\alpha_F I_{ES} = \frac{eA_{bc} D_n n_{b0}}{W_{bc} - W_{be}}$$

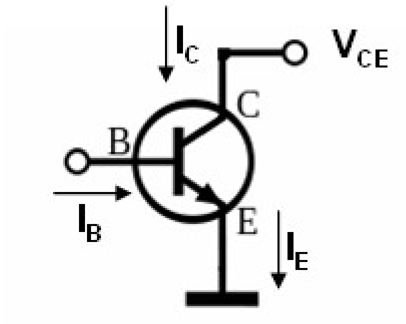
$$I_{CS} = \left[\frac{eA_{bc} D_p p_{c0}}{x_c - W_c} + \frac{eA_{bc} D_n n_{b0}}{W_{bc} - W_{be}} \right]$$

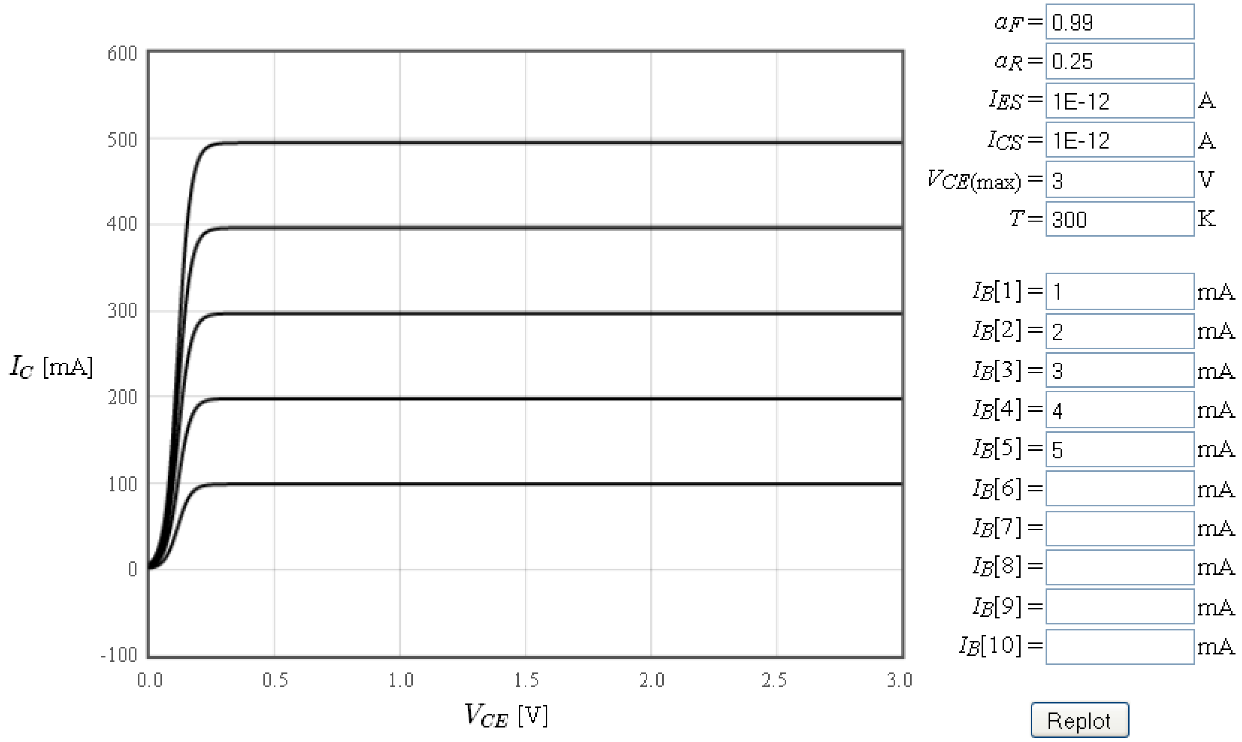
Common emitter configuration

$$I_E = I_{ES}\left(e^{eV_{be}/k_BT}-1\right)-\alpha_R I_{CS}\left(e^{eV_{bc}/k_BT}-1\right)$$

$$I_B = I_E - I_C$$

$$I_c = \alpha_F I_{ES}\left(e^{eV_{be}/k_BT}-1\right)-I_{CS}\left(e^{eV_{bc}/k_BT}-1\right)$$





$\alpha_F =$ 0.99

$\alpha_R =$ 0.25

$I_{ES} =$ 1E-12 A

$I_{CS} =$ 1E-12 A

V_{CE}(max) = 3 V

$T =$ 300 K

$I_B[1] =$ 1 mA

$I_B[2] =$ 2 mA

$I_B[3] =$ 3 mA

$I_B[4] =$ 4 mA

$I_B[5] =$ 5 mA

$I_B[6] =$ mA

$I_B[7] =$ mA

$I_B[8] =$ mA

$I_B[9] =$ mA

$I_B[10] =$ mA

current amplification ~100

http://lamp.tu-graz.ac.at/~hadley/psd/L13/commonemitter.php

Current amplification factor

$$\beta = h_{fe} = \frac{I_C}{I_B}$$

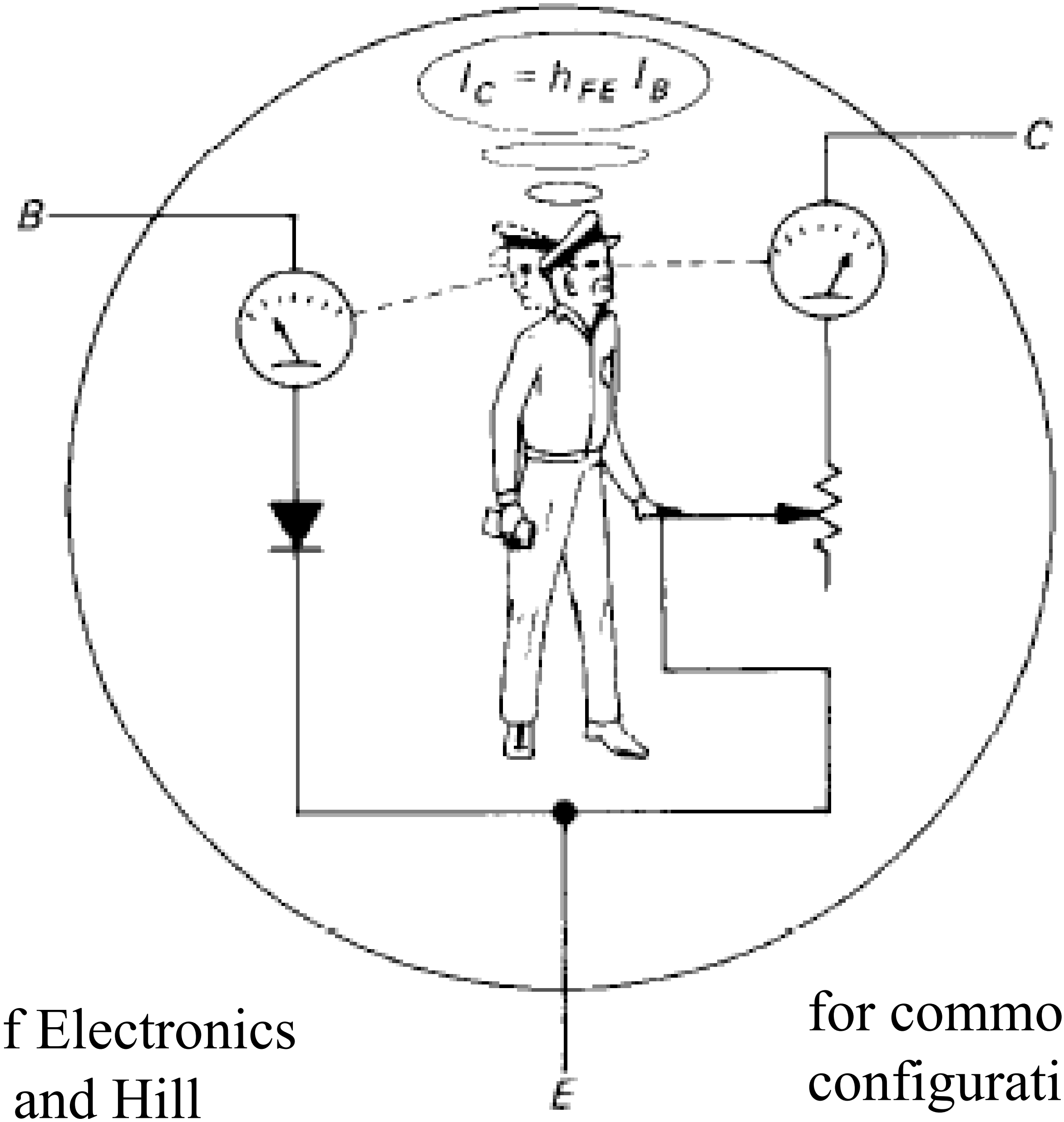
$$I_B = I_E - I_C$$

$$I_C = \alpha I_E$$

$$I_B = \left(\frac{1}{\alpha} - 1 \right) I_C$$

$$\beta = \frac{I_C}{I_B} = \frac{\alpha}{1-\alpha} = \frac{B\gamma_e}{1-B\gamma_e}$$

$\beta \sim 50 - 500$



The Art of Electronics
Horowitz and Hill

for common emitter
configuration

"Transistor man"

Transconductance

$$g_m = \frac{\partial I_C}{\partial V_{be}}$$

$$I_c = \alpha_F I_{ES} \left(e^{eV_{be}/k_B T} - 1 \right) - I_{CS} \left(e^{eV_{bc}/k_B T} - 1 \right)$$

The first term depends on V_{be}

$$g_m = \frac{e\alpha_F I_{ES}}{k_B T} e^{eV_{be}/k_B T} \approx \frac{eI_C}{k_B T} = \frac{e\beta I_B}{k_B T}$$

The transconductance can be very high.

Early effect

Ebers - Moll:

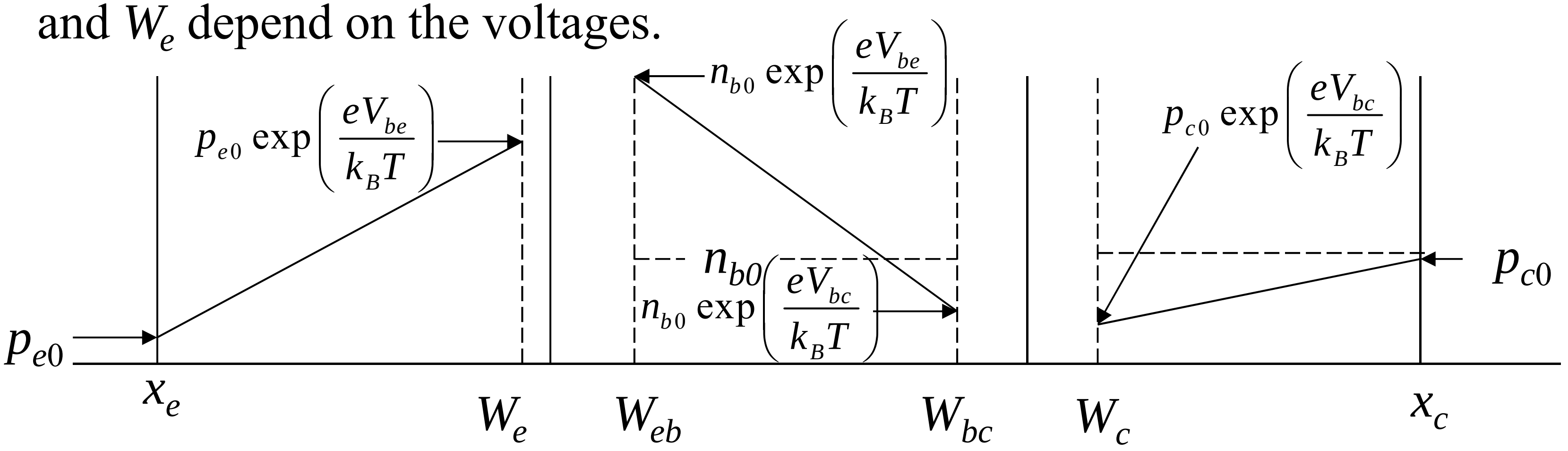
$$I_E = I_{ES}\left(e^{eV_{be}/k_BT}-1\right)-\alpha_R I_{CS}\left(e^{eV_{bc}/k_BT}-1\right)$$

$$I_c = \alpha_F I_{ES}\left(e^{eV_{be}/k_BT}-1\right)-I_{CS}\left(e^{eV_{bc}/k_BT}-1\right)$$

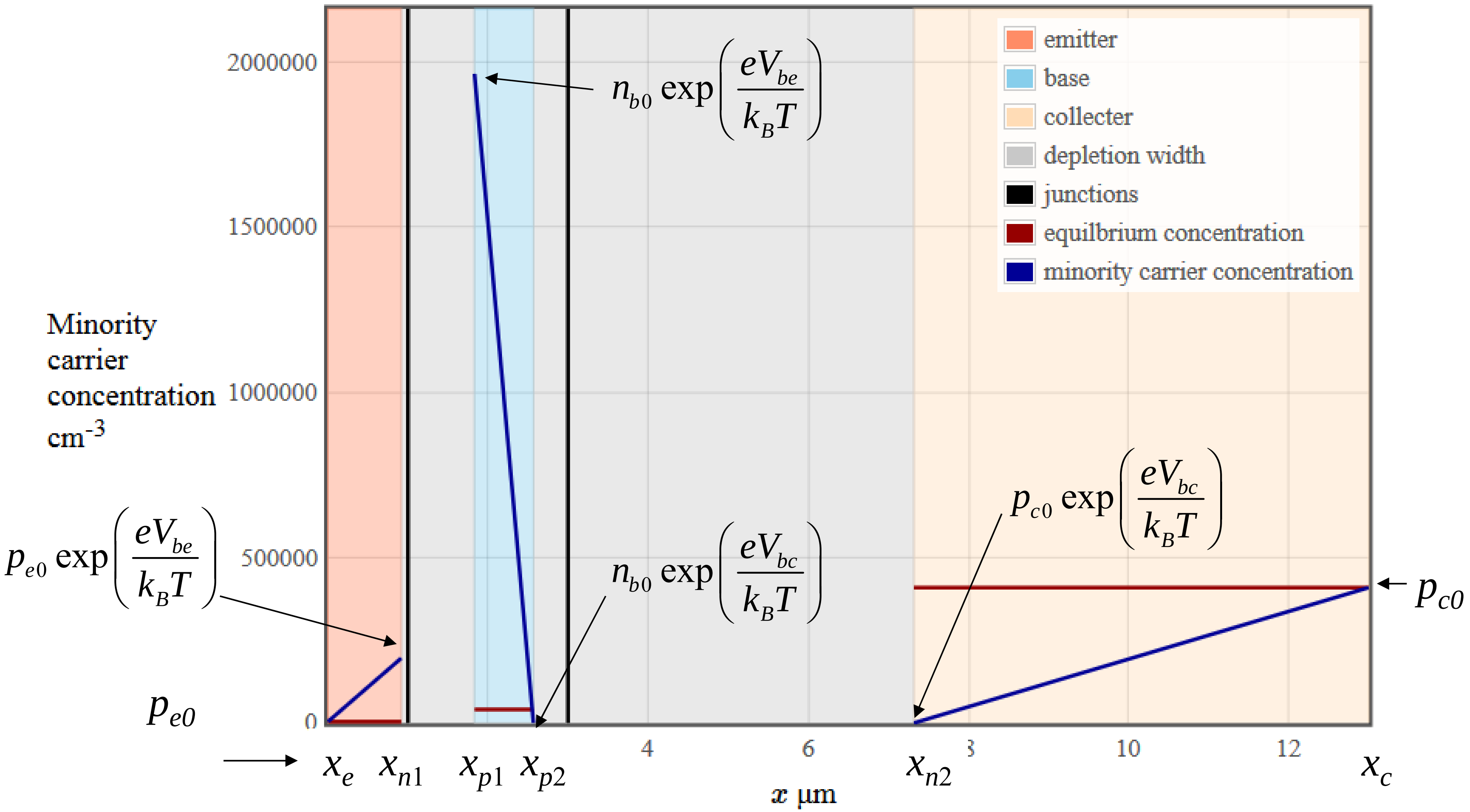
$$I_B = I_E - I_C$$

$$I_{ES} = \left[\frac{eA_{be}D_p p_{e0}}{W_{eb}-x_e}+\frac{eA_{be}D_n n_{b0}}{W_{bc}-W_{be}}\right] \qquad I_{CS} = \left[\frac{eA_{bc}D_p p_{c0}}{x_c-W_c}+\frac{eA_{bc}D_n n_{b0}}{W_{bc}-W_{be}}\right]$$

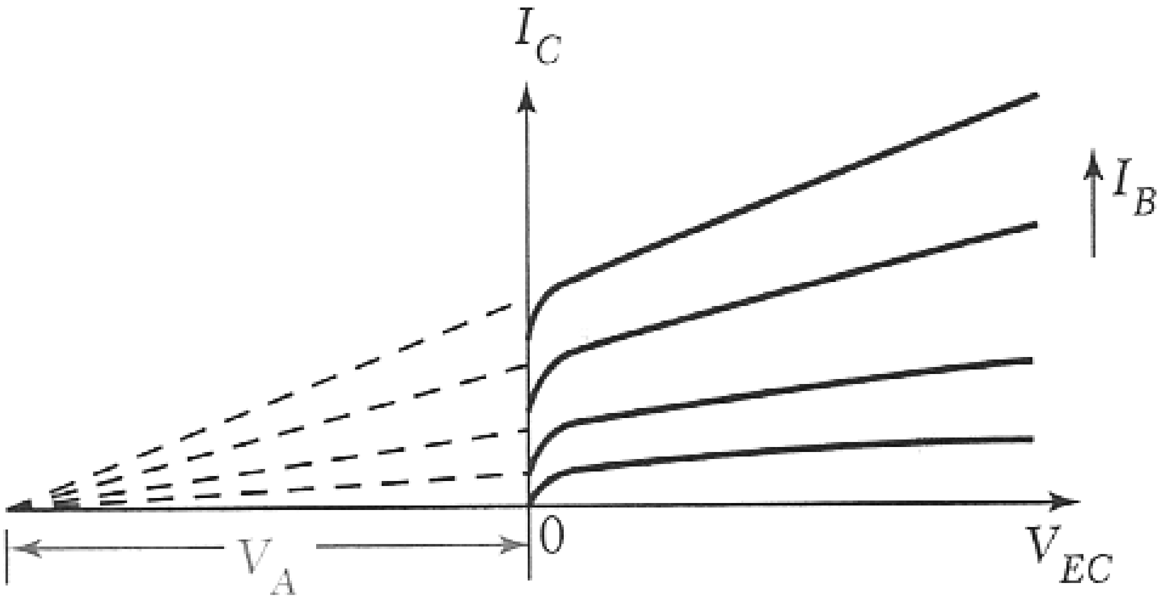
I_{ES} and I_{CS} are treated as constants but the depletion widths W_{bc}, W_{be}, W_c, and W_e depend on the voltages.



Minority carrier concentration



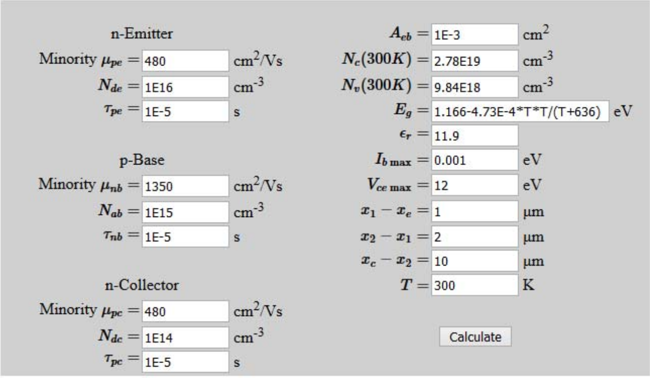
Early effect



Common emitter configuration
Base width modulation: smaller width increases the diffusion current and increases the gain.

Punchthrough: The neutral base width goes to zero and all gain is lost.
Lightly dope the collector -> voltage drops in collector. Makes circuit slower.

NPN common emitter configuration



n-Emitter

Minority $\mu_{pe} =$ 480 $\mathrm{cm^2/Vs}$

$N_{de} =$ 1E16 $\mathrm{cm^{-3}}$

$\tau_{pe} =$ 1E-5 s

p-Base

Minority $\mu_{nb} =$ 1350 $\mathrm{cm^2/Vs}$

$N_{ab} =$ 1E15 $\mathrm{cm^{-3}}$

$\tau_{nb} =$ 1E-5 s

n-Collector

Minority $\mu_{pc} =$ 480 $\mathrm{cm^2/Vs}$

$N_{dc} =$ 1E14 $\mathrm{cm^{-3}}$

$\tau_{pc} =$ 1E-5 s

$A_{eb} =$ 1E-3 $\mathrm{cm^2}$

$N_c(300K) =$ 2.78E19 $\mathrm{cm^{-3}}$

$N_v(300K) =$ 9.84E18 $\mathrm{cm^{-3}}$

$E_g =$ 1.166-4.73E-4*T*T/(T+636) eV

$\epsilon_r =$ 11.9

$I_{b\,\mathrm{max}} =$ 0.001 eV

$V_{ce\,\mathrm{max}} =$ 12 eV

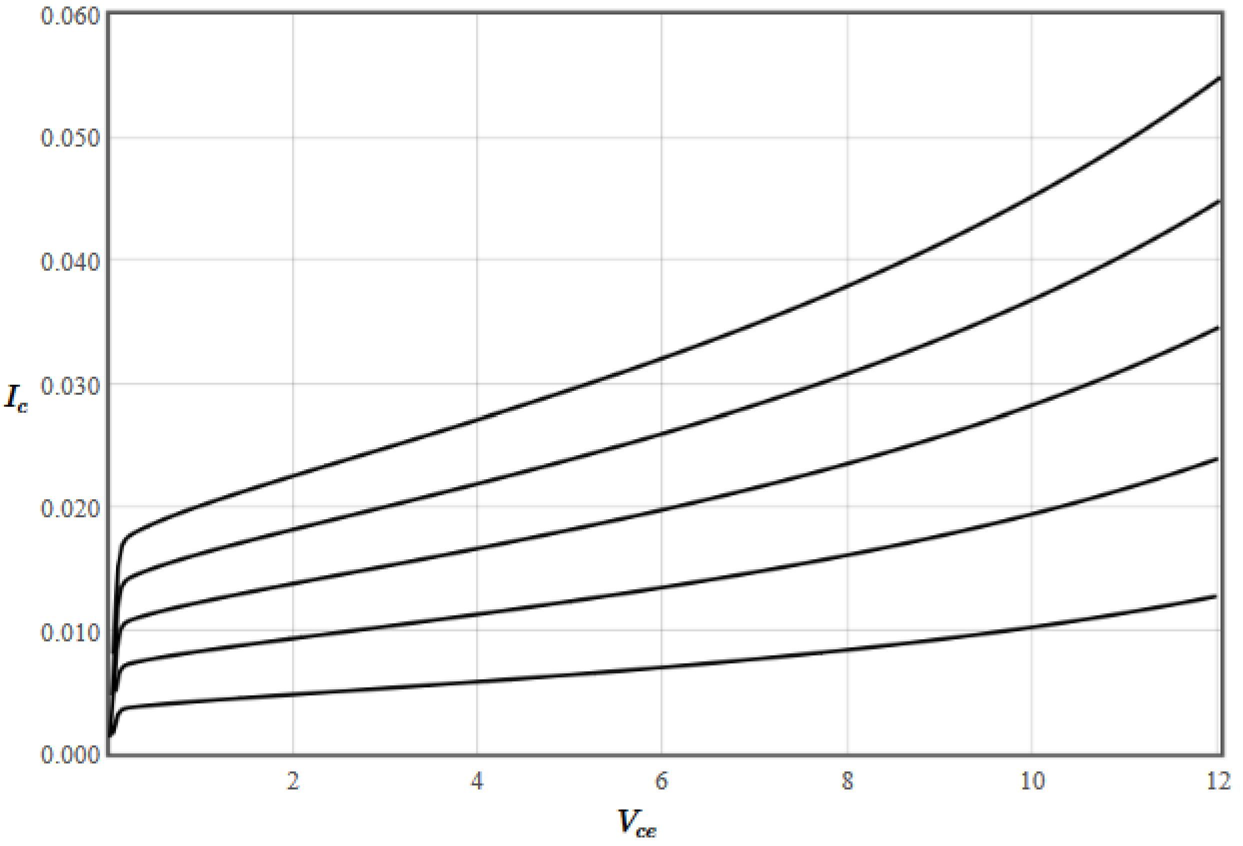
$x_1 - x_e =$ 1 μm

$x_2 - x_1 =$ 2 μm

$x_c - x_2 =$ 10 μm

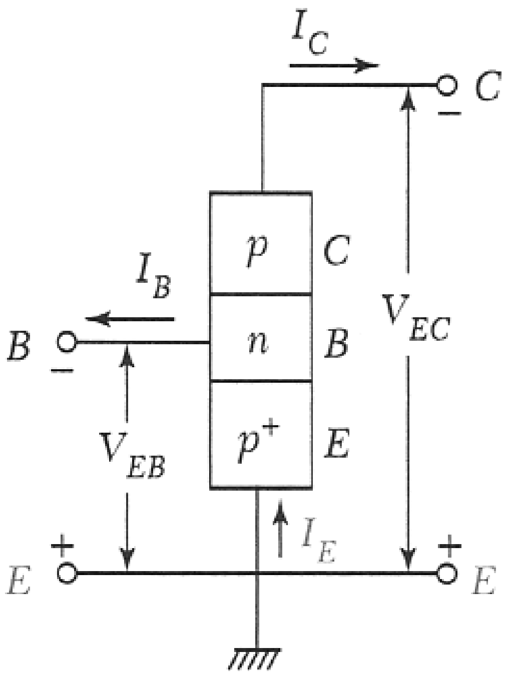
$T =$ 300 K

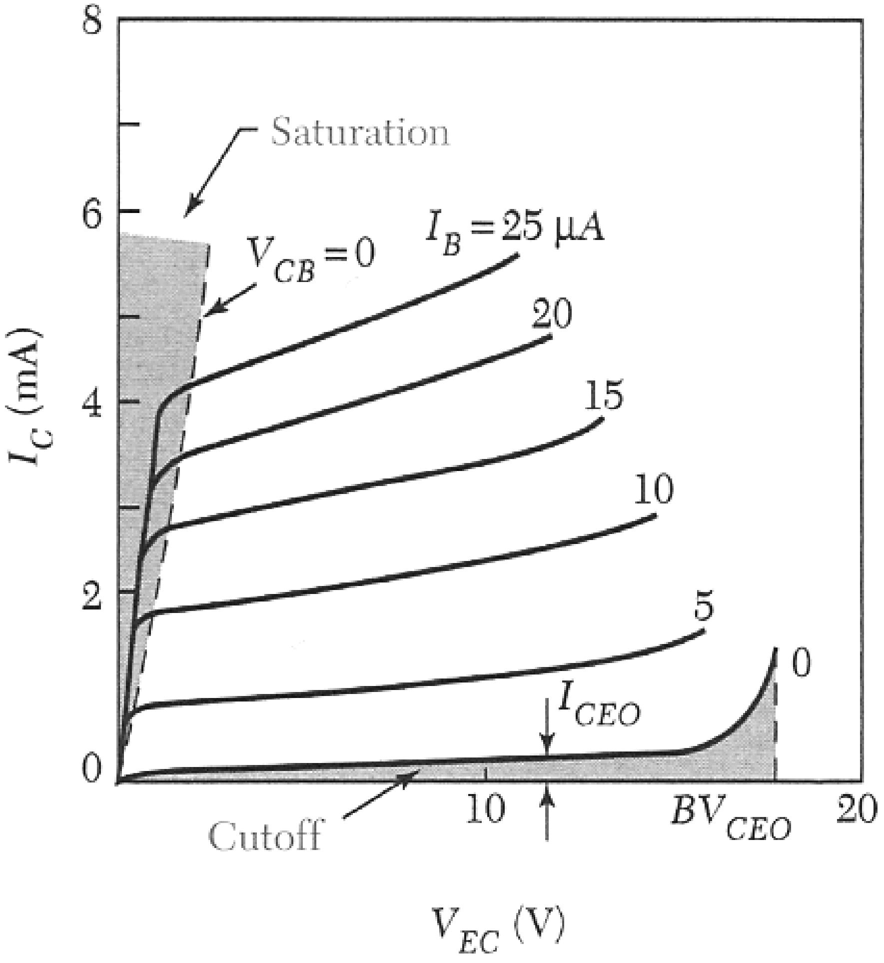
$$I_C \sim \beta I_B$$



http://lampx.tugraz.at/~hadley/psd/L13/common_e_early.php

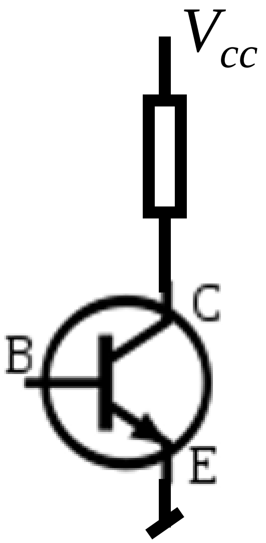
Common emitter configuration



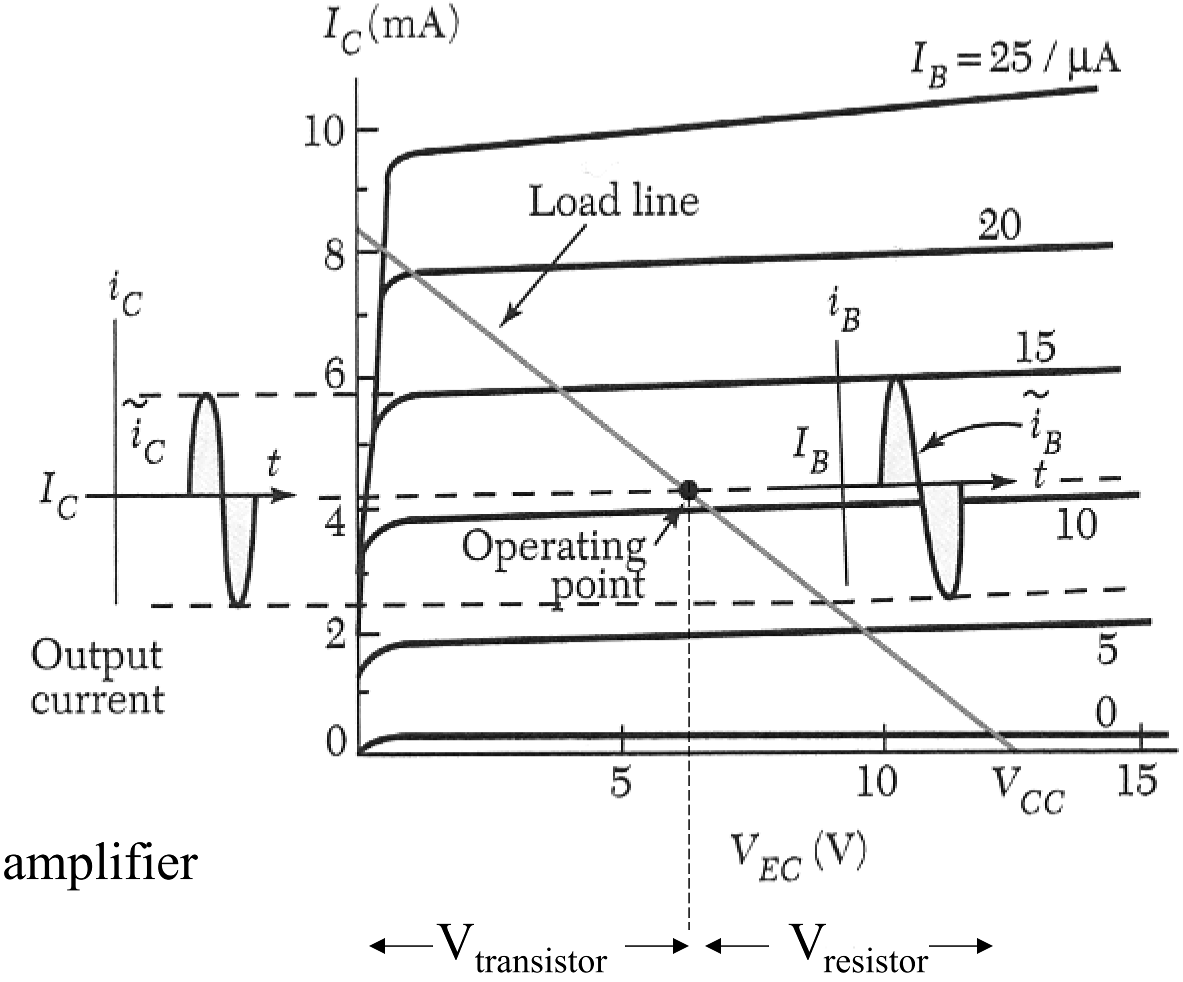


$I_C \sim \beta I_B$ amplifier

Small signal response

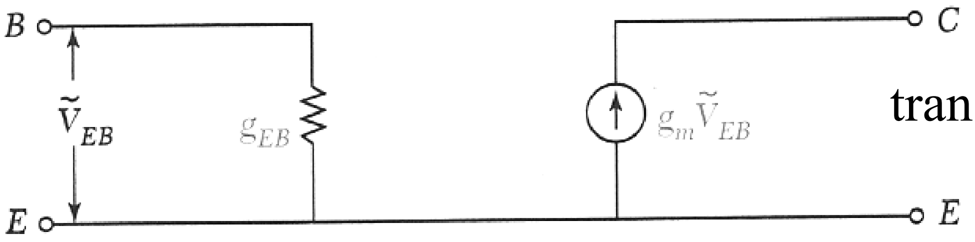


Low input impedance amplifier



Small signal response

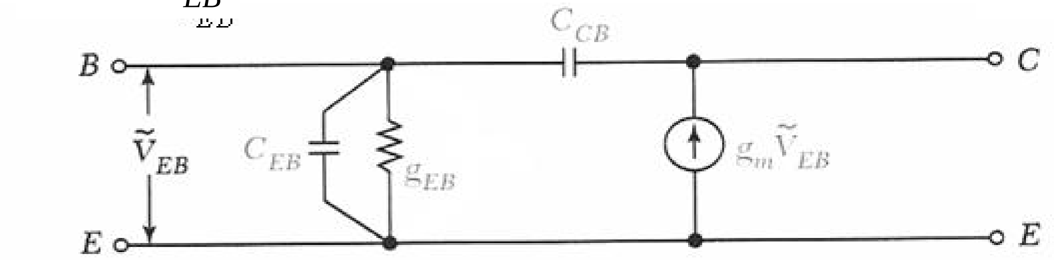
$$\tilde{i}_c = \beta \tilde{i}_B = \beta g_{EB} \tilde{v}_{EB}$$

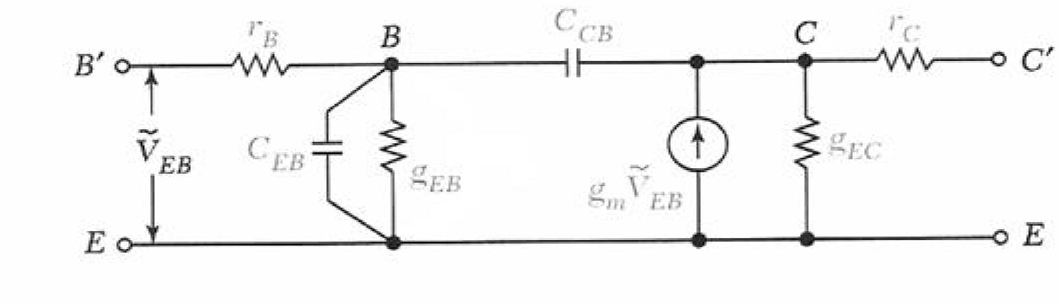


transistor man

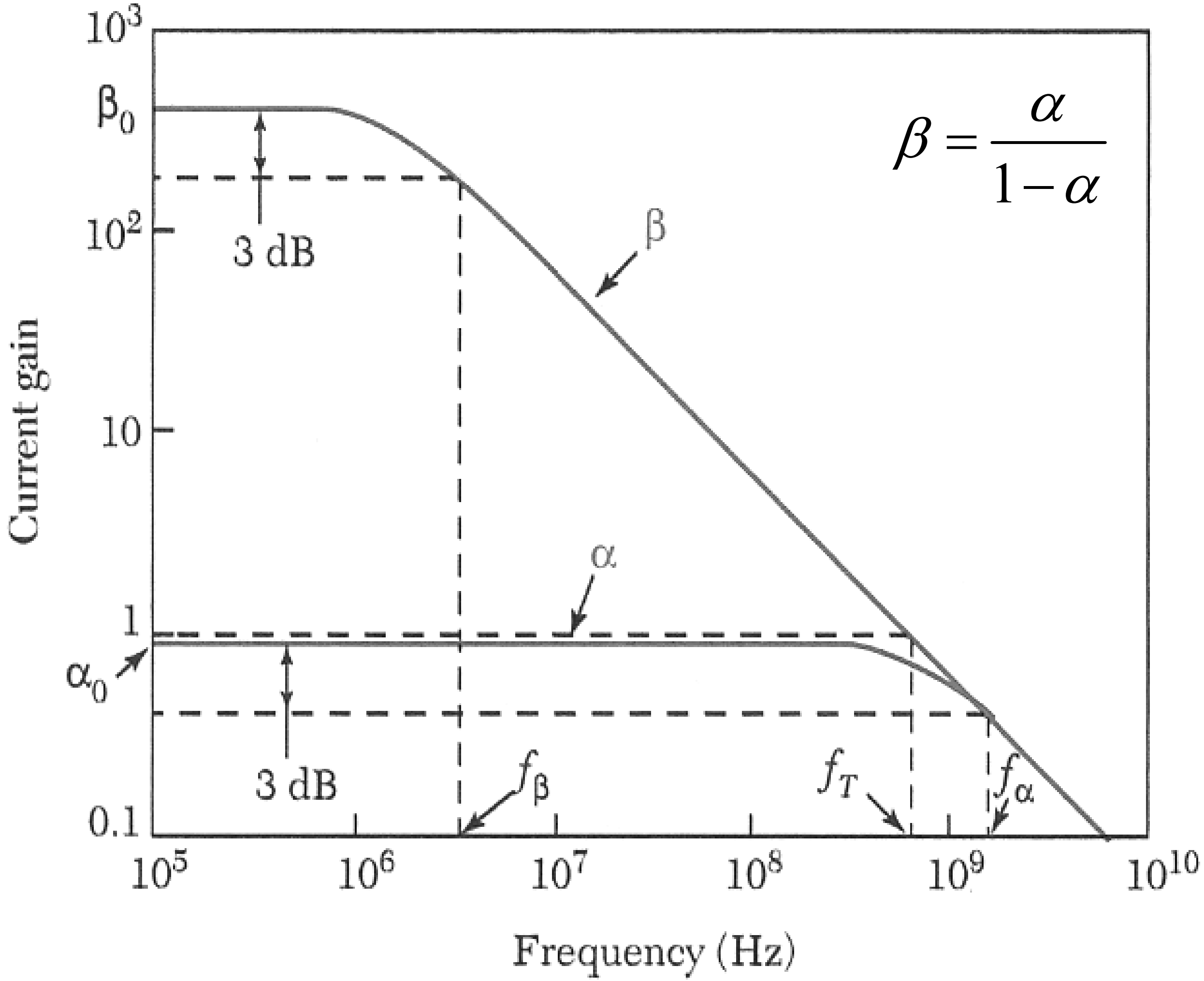
input conductance: $$g_{EB} = \frac{\tilde{i}_B}{\tilde{v}_{EB}}$$

transconductance: $$g_m = \frac{\tilde{i}_c}{\tilde{v}_{EB}}$$





Small signal response



$$\beta = \frac{\alpha}{1-\alpha}$$

$$f_\beta = \left(1-\alpha_0\right) f_\alpha \qquad f_T = \alpha_0 f_\alpha$$